

Notice of References Cited	Application/Control No. 10/505,439	Applicant(s)/Patent Under Reexamination IDE ET AL.	
	Examiner George R. Koch III	Art Unit 1734	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
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FOREIGN PATENT DOCUMENTS

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	N	JP H11-33366	02-1999	Japan	Akihiro et al.	N/A
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NON-PATENT DOCUMENTS

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